



Silicon N-Channel Power MOSFET



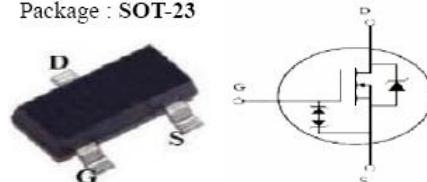
F601D-G

Features:

- | N-Channel
- | ESD improved Capability
- | Depletion Mode
- | dv/dt rated
- | Pb-free lead plating; ROHS compliant
- | Halogen Free

V _{DSX}	600	V
I _{DSS,min}	0.012	A
R _{DS(ON),max}	300	Ω

Package : SOT-23

**Absolute** (T_c= 25°C unless otherwise specified):

Symbol	Parameter	Rating	Units
V _{DSX}	Drain-to-Source Voltage	600	V
I _D	Continuous Drain Current	0.030	A
	Continuous Drain Current T _C =70 °C	0.024	A
I _{DM} ^{a1}	Pulsed Drain Current	0.120	A
V _{GS}	Gate-to-Source Voltage	±20	V
dv/dt ^{a2}	Peak Diode Recovery dv/dt	5.0	V/ns
P _D	Power Dissipation	0.5	W
V _{ESD(G-S)}	Gate source ESD (HBM-C= 100pF, R=1.5kΩ)	1200	V
T _J , T _{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	°C

Electrical Characteristics (T_c= 25°C unless otherwise specified):

OFF Characteristics						Units	
Symbol	Parameter	Test Conditions	Rating				
			Min.	Typ.	Max.		
V _{DSX}	Drain to Source Breakdown Voltage	V _{GS} =-5V, I _D =250μA	600	--	--	V	
I _{D(off)}	Off-state Drain to Source Current	V _{DS} =600V, V _{GS} = -5V	--	--	0.1	μA	
		V _{DS} =480V, V _{GS} = -5V Ta=125°C			10	μA	
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} =+20V	--	--	10	μA	
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} =-20V	--	--	-10	μA	

**ON Characteristics**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
Idss	On-state drain current	V _{GS} =0V, V _{DS} =25V	12			mA
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =0V, I _D =3mA	--	100	300	Ω
		V _{GS} =10V, I _D =16mA		85	300	
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =3V, I _D =8.0μA	-2.7		-1.0	V

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g _{fs}	Forward Trans conductance	V _{DS} =50V, I _D =0.01A		0.005	--	S
C _{iss}	Input Capacitance	V _{GS} =-5V V _{DS} = 25V f = 1.0MHz	--	15.5		pF
			--	4.7		
			--	1.6		
C _{rss}	Reverse Transfer Capacitance					

Resistive Switching Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D =0.01A V _{DD} =300V V _{GS} = -5...7V R _G = 6.0Ω	--	6.6	--	ns
t _r	Rise Time		--	21.6	--	
t _{d(OFF)}	Turn-Off Delay Time		--	6.2	--	
t _f	Fall Time		--	96.4	--	

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current (Body Diode)	Ta=25° C	--	--	0.025	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	0.100	A
V _{SD}	Diode Forward Voltage	I _F =16mA, V _{GS} = -5V	--	--	1.2	V

Symbol	Parameter	Max.			Units
R _{θ JA}	Junction-to-Ambient	250			°C/W

**Gate-source Zener diode**

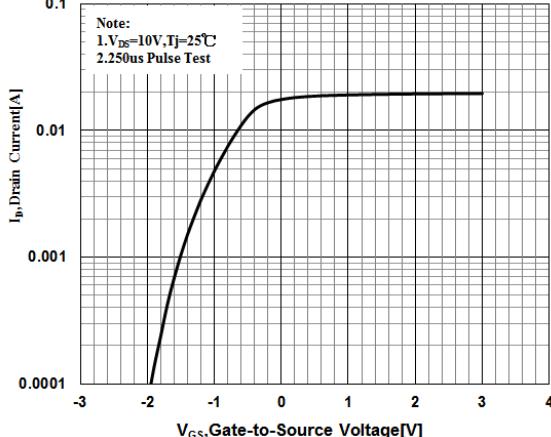
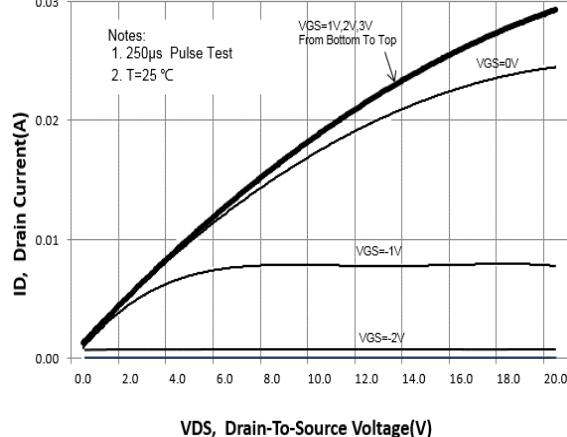
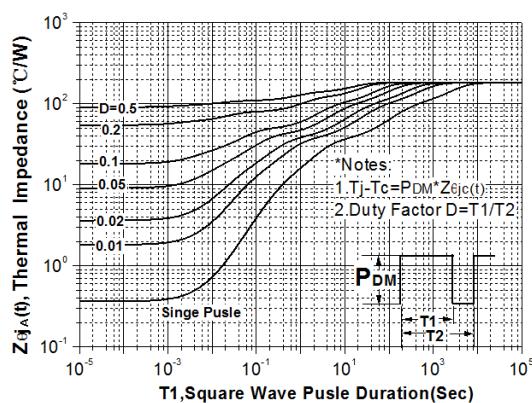
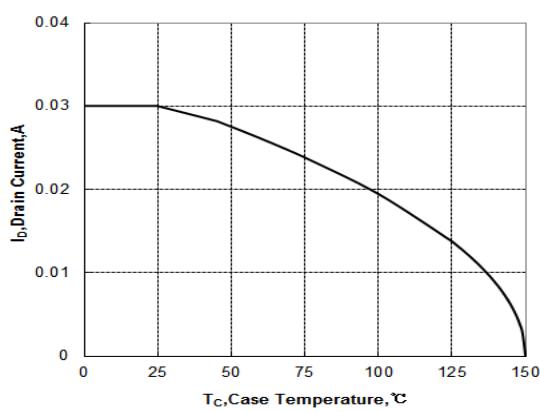
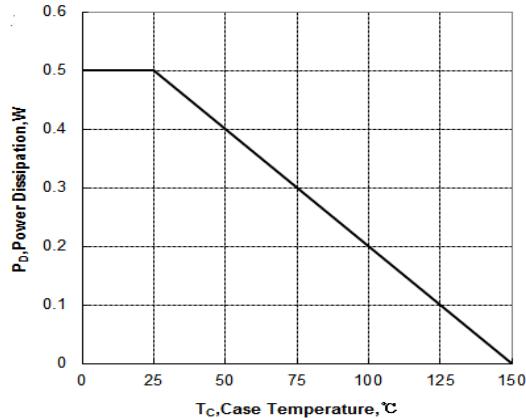
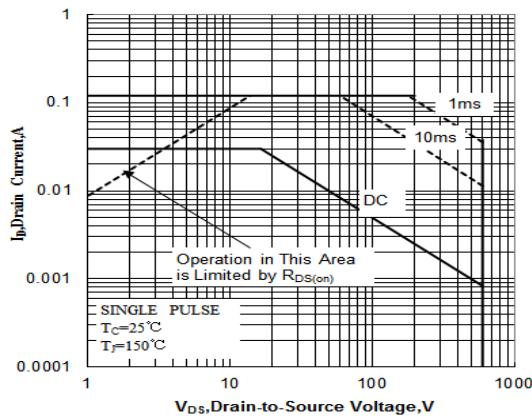
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 1\text{mA}$ (Open Drain)	20			V
The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.						

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature

^{a2}: $I_F = 0.01\text{A}, di/dt \leq 100\text{A/us}, V_{DD} \leq BV_{DS}$, Start $T_J = 25^\circ\text{C}$

^{a3}: Recommend soldering temperature defined by IPC/JEDEC J-STD 020

Characteristics Curve:



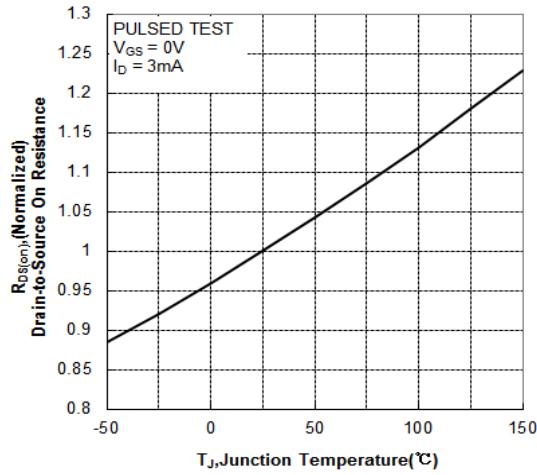


Figure 7 Typical Drian to Source on Resistance vs Junction Temperature

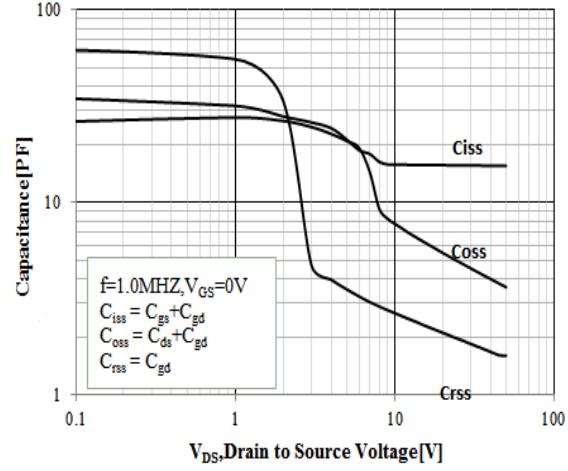


Figure 8 Typical Capacitance vs Drain to Source Voltage

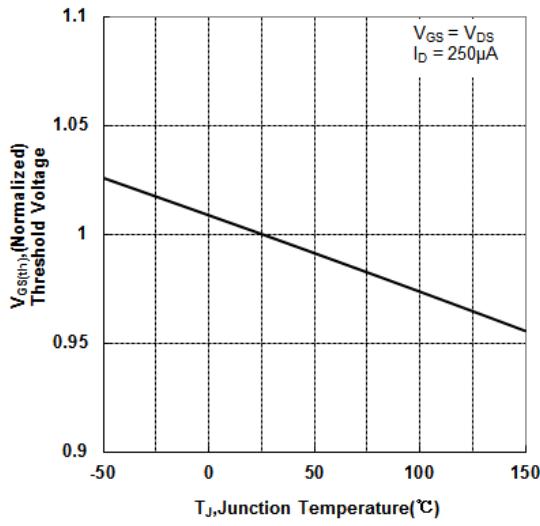


Figure 9 Typical Theshold Voltage vs Junction Temperature

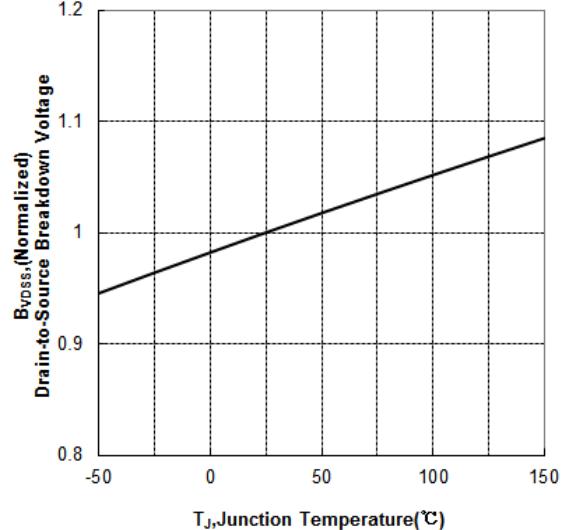


Figure 10 Typical Breakdown Voltage vs Junction Temperature

Test Circuit and Waveform

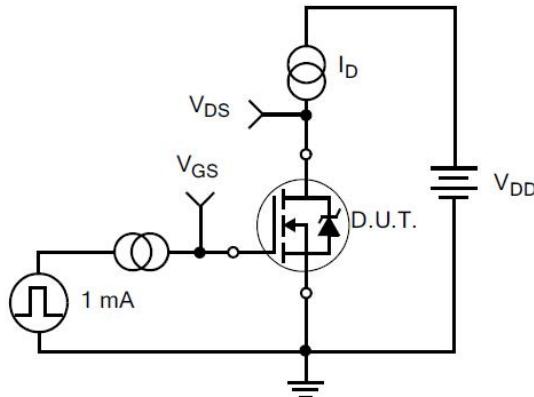


Figure 11. Gate Charge Test Circuit

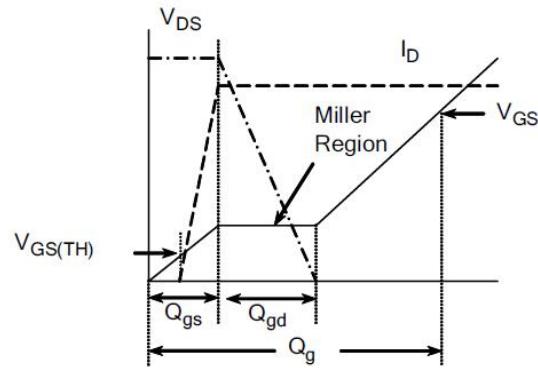


Figure 12. Gate Charge Waveforms

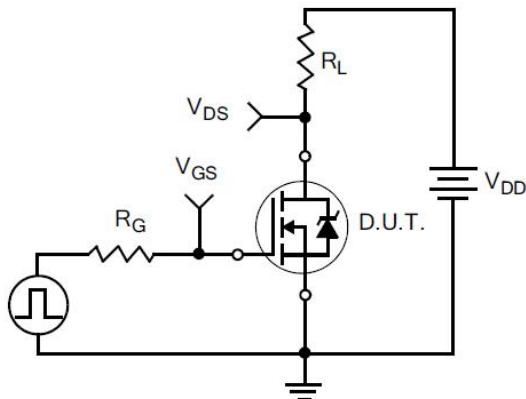


Figure 13. Resistive Switching Test Circuit

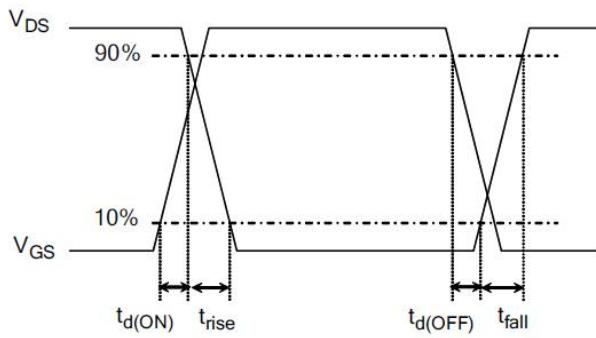


Figure 14. Resistive Switching Waveforms

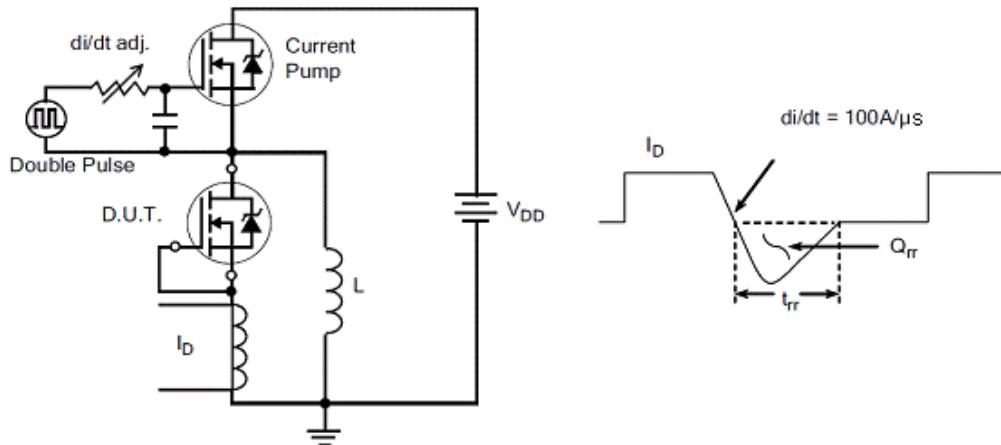


Figure 15. Diode Reverse Recovery Test Circuit

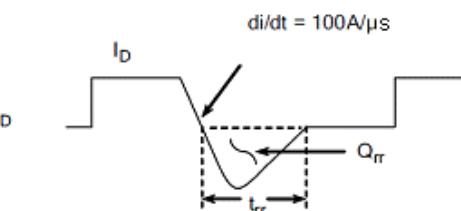


Figure 16. Diode Reverse Recovery Waveform

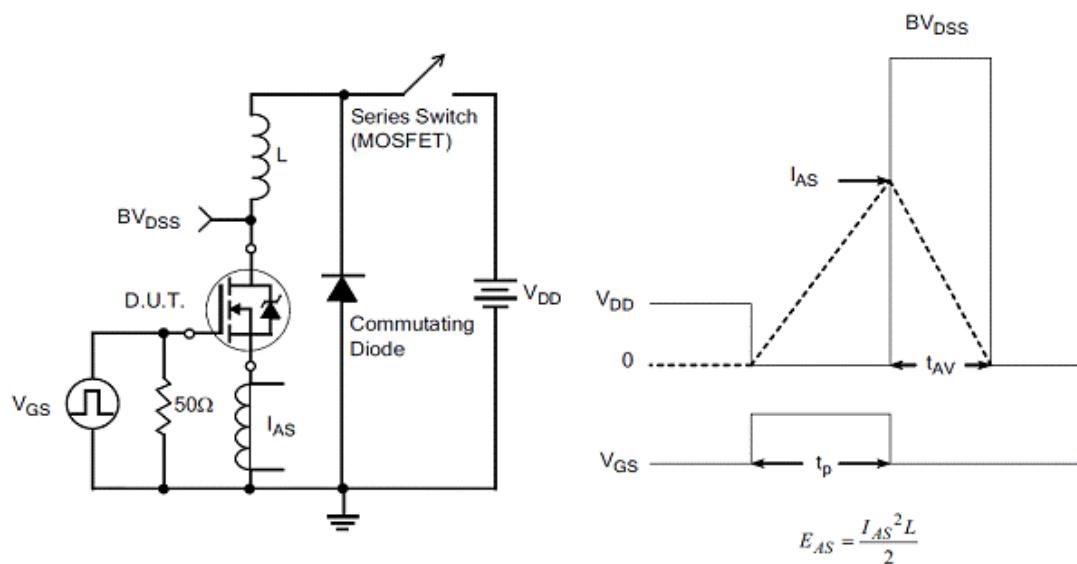
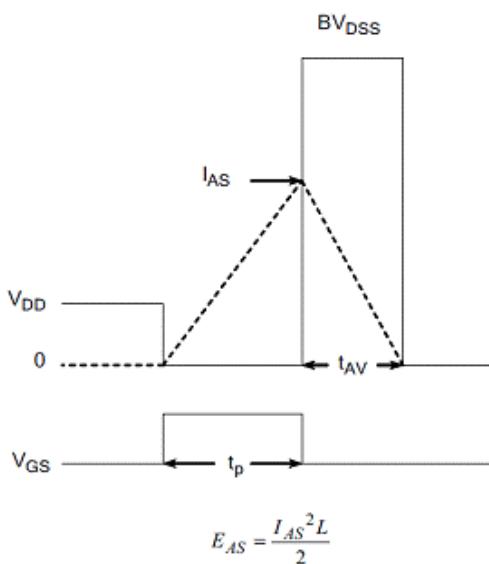
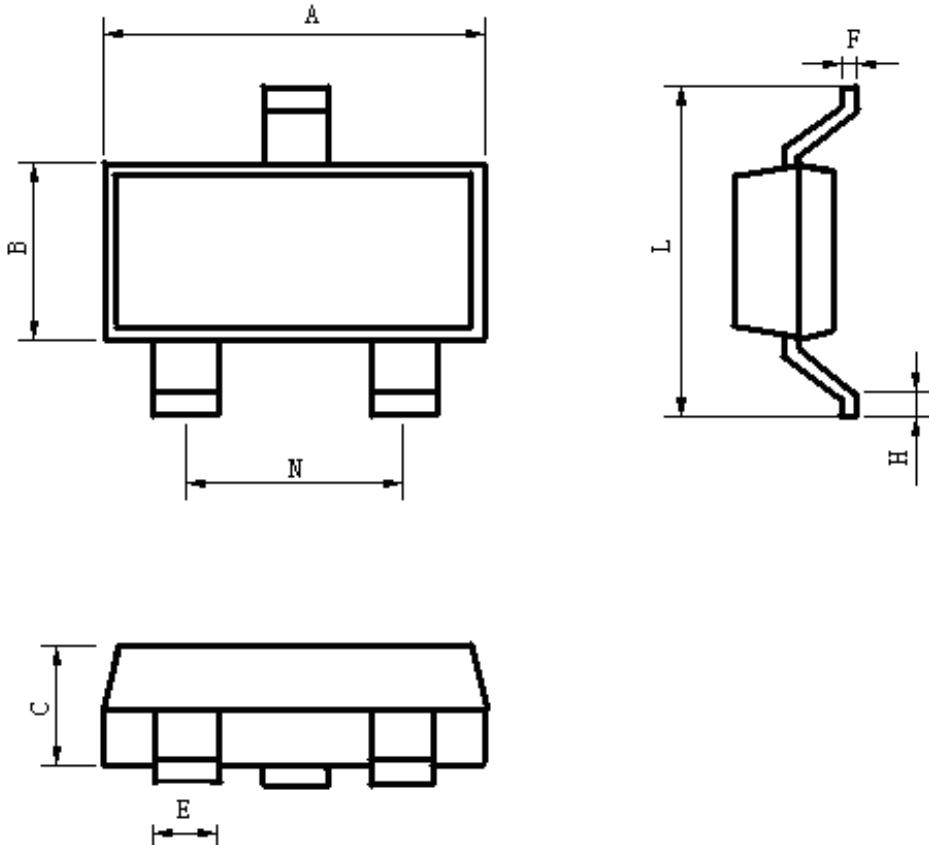


Figure 17.Unclamped Inductive Switching Test Circuit

Figure 18.Unclamped Inductive Switching Waveform



$$E_{AS} = \frac{I_{AS}^2 L}{2}$$

Package Information:

Items	Values(mm)	
	MIN	MAX
A	2.70	3.10
B	1.10	1.50
C	0.90	1.10
E	0.25	0.55
F	0.07	0.23
H	0.25	0.55
L	2.20	2.60
N	1.80	2.00

SOT-23 Package



The name and content of poisonous and harmful material in products

Part's Name	Hazardous Substance									
	Pb	Hg	Cd	Cr(VI)	PBB	PBDE	DIBP	DEHP	DBP	BBP
Limit	≤0.1%	≤0.1%	≤0.01 %	≤0.1%	≤0.1%	≤0.1%	≤0.1%	≤0.1%	≤0.1%	≤0.1%
Lead Frame	○	○	○	○	○	○	○	○	○	○
Molding	○	○	○	○	○	○	○	○	○	○
Chip	○	○	○	○	○	○	○	○	○	○
Wire Bonding	○	○	○	○	○	○	○	○	○	○
Electric glue	○	○	○	○	○	○	○	○	○	○
Note	○: Means the hazardous material is under the criterion of 2011/65/EU. ✗: Means the hazardous material exceeds the criterion of 2011/65/EU. The plumbum element of solder exist in products presently, but within the allowed range of Eurogroup's RoHS.									

Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
2. When installing the heatsink, please pay attention to the torsional moment and the smoothness of the heatsink.
3. VDMOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. This publication is made by Huajing Microelectronics and subject to regular change without notice.

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